


<b>Search Notes</b>  	<b>Application/Control No.</b>  10566136	<b>Applicant(s)/Patent Under Reexamination</b>  HAY, ORI
	<b>Examiner</b>  JON CHANG	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	294 (text limited)	9/2/08 (updated on 03/31/09)	
382	287 (text limited)	9/2/08 (updated on 03/31/09)	SK (JC)
382	128 (text limited)	9/2/08 (updated on 03/31/09)	SK (JC)
382	130, 131, 132, 199, 276, 277, 293, 294-296, 298	03/31/09	JC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search (US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, Derwent, IBM, TD) - see search history printout	03/31/09	JC
Inventor Search	03/31/09	JC
EAST Search (see search history printout)	09/18/09	JC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Interference Search History Printout	09/18/09	JC

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